

Notice of References Cited	Application/Control No. 10/598,971		Applicant(s)/Patent Under Reexamination OSHIYAMA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0068526 A1	04-2003	Kamatani et al.	428/690
*	B	US-2004/0058194 A1	03-2004	Stossel et al.	428/690
	C	US-			
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NON-PATENT DOCUMENTS

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